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8

l v_{cc}

7 1 1Y

6 3A

5 2Y

DCT PACKAGE (TOP VIEW)

1A

GND [

3Y 🚺 2

2A 🛛 3

4

- *EPIC*[™] (Enhanced-Performance Implanted CMOS) Process
- Operating Range 2-V to 5.5-V V_{CC}
- Packaged in Plastic Small-Outline Transistor Package

description

The SN74AHC2G04 contains three independent inverter gates. The device performs the Boolean function $Y = \overline{A}$.

The SN74AHC2G04 is characterized for operation from -40°C to 85°C.

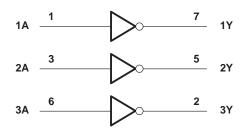
FUNCTION TABLE (each inverter)					
INPUT A	OUTPUT Y				
Н	L				
L H					

logic symbol[†]

	1		1. 7	,
1 A		1	<u> </u>	– 1Y
2A	3		5	, - 2Y
	6		2	2 - 3Y
3A				- 3ĭ

[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagram (positive logic)





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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage range, V_{CC} Input voltage range, V_I (see Note 1) Output voltage range, V_O (see Note 1) Input clamp current, I_{IK} ($V_I < 0$) Output clamp current, I_{OK} ($V_O < 0$ or $V_O > V_{CC}$) Continuous output current, I_O ($V_O = 0$ to V_{CC}) Continuous current through V_{CC} or GND Package thermal impedance, θ_{JA} (see Note 2) Storage temperature range Teta	-0.5 V to 7 V 0.5 V to V _{CC} + 0.5 V -20 mA ±20 mA ±25 mA ±50 mA
Storage temperature range, T _{stg}	

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

2. The package thermal impedance is calculated in accordance with JESD 51.

recommended operating conditions

			MIN	MAX	UNIT
VCC	Supply voltage	_	2	5.5	V
		$V_{CC} = 2 V$	1.5		
VIH	High-level input voltage	V _{CC} = 3 V	2.1		V
		V _{CC} = 5.5 V	3.85		
		$V_{CC} = 2 V$		0.5	
VIL	Low-level input voltage	V _{CC} = 3 V		0.9	V
		V _{CC} = 5.5 V		V _{CC} V	
VI	Input voltage		0	5.5	V
VO	Output voltage		0	VCC	V
		$V_{CC} = 2 V$		-50	μA
IOH	High-level output current	V_{CC} = 3.3 V ± 0.3 V		-4	mA
		$V_{CC} = 5 V \pm 0.5 V$	2 5.5 1.5 2.1 3.85 0.5 0.9 1.65 0 5.5 0 V _{CC} -50	ША	
		$V_{CC} = 2 V$		50	μΑ
IOL	Low-level output current	V_{CC} = 3.3 V ± 0.3 V		4	mA
		$V_{CC} = 5 V \pm 0.5 V$		8	ША
Δt/Δv	Input transition rise or fall rate	V_{CC} = 3.3 V ± 0.3 V		100	ns/V
ΔUΔV	Input transition rise or fall rate	V_{CC} = 5 V ± 0.5 V		20	115/ V
TA	Operating free-air temperature		-40	85	°C



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PARAMETER	TEST CONDITIONS	Vaa	T _A = 25°C			MIN		UNIT
PARAMETER	TEST CONDITIONS	V _{CC} MIN	TYP	MAX	IVIIIN	MAX	UNIT	
		2 V	1.9	2		1.9		
	I _{OH} = -50 μA	3 V	2.9	3		2.9		
VOH		4.5 V	4.4	4.5		4.4		V
	I _{OH} = -4 mA	3 V	2.58			2.48		
	I _{OH} = -8 mA	4.5 V	3.94			3.8		
		2 V			0.1		0.1	
	I _{OL} = 50 μA	3 V			0.1		0.1	
VOL		4.5 V			0.1		0.1	V
	$I_{OL} = 4 \text{ mA}$	3 V			0.36		0.44	
	I _{OL} = 8 mA	4.5 V			0.36		0.44	
lı	$V_{I} = V_{CC} \text{ or } GND$	5.5 V			±0.1		±1	μA
ICC	$V_{I} = V_{CC} \text{ or } GND, \qquad I_{O} = 0$	5.5 V			1		10	μA
Ci	$V_{I} = V_{CC} \text{ or } GND$	5 V						pF

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

switching characteristics over recommended operating free-air temperature range, V_{CC} = 3.3 V \pm 0.3 V (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	то	LOAD	T _A = 25°C	MIN MAX	UNIT
PARAMETER	(INPUT)	(OUTPUT)	CAPACITANCE	MIN TYP MAX		UNIT
^t PLH		Y	C _L = 15 pF			nc
^t PHL	A					ns
^t PLH	A	V	$C_{1} = 50 \text{ pF}$			ns
^t PHL		I	C _L = 50 pF			115

switching characteristics over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V (unless otherwise noted) (see Figure 1)

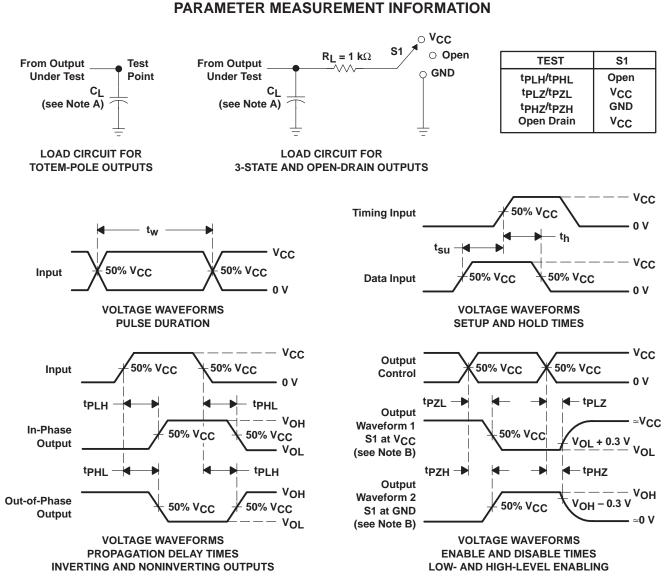
Γ	PARAMETER	FROM	то	LOAD	T _A = 25°C	
	FARAINETER	(INPUT)	(OUTPUT)	CAPACITANCE	MIN TYP MAX	
	^t PLH	٨	v	$C_{\rm L} = 15 \rm pE$		
Γ	^t PHL	A	T	C _L = 15 pF		ns
	^t PLH	Δ.	X	C _L = 50 pF		
Γ	^t PHL	А			CL = 50 pr	

operating characteristics, V_{CC} = 5 V, T_A = 25°C

PARAMETER		TEST CO	ONDITIONS	TYP	UNIT
Cpd	Power dissipation capacitance	No load,	f = 1 MHz		pF

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NOTES: A. CL includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, Z_O = 50 Ω , t_f \leq 3 ns, t_f \leq 3 ns.

D. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms



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